		-								1		
				OR EXTENSIO	N OF ESC	OF ESCC QUALIFICATION APPROVAL				Page 1		
E E	SCC	С	Component Title: Schottky Barrier Pov			wer Diodes based on type STPS				Appl. No.		
		E	executive Member: C	Date: 03/03/2020				272H-rev2	2			
Components (includi	ng series and famil	ies) s	ubmitted for Extension o	of Qualification	Approval:						1	
ESCC			[
COMPONENT NO.	VARIANTS		RANGE OF COM	PONENTS	BASED ON			TEST VEHICLE / S		COMPONENT SIMILAR		
5106/016	05, 06, 07, 11		TO-254, SMD0.5, SMD1		STPS20100			33420006ZM TO254				
5106/017	01, 02		SMD0.5		STPS10	045		33510003ZE SMD.5				
5106/018 5106/019	02 03, 05		SMD1 TO254, SMD1	STPS6045 STPS40100			33652003ZU SMD.5 33633001ZZ SMD1					
5106/023 01, 02, 03, 04		SMD.5, TO-254AA		STPS60A15 STPS80A15 STPS40A15)						
5106/024	01, 02, 03		SMD.5, TO-254AA		STPS80 STPS40)A450	;	ID33652003ZU SMD.5				
Component M	anufacturer	2	Location of Man	ufacturing Plant(3	,	SWD.5	1		4	
STMicroelectronics			3, rue de Suisse BP41	5			Date Date:	of original qualification ap 01/11/2002	oprova	l:		
							Certif	icate Ref No. 272				
		5				6					7	
ESCC Specifications Maintenance of quali			Deviations to LVT test used:	ting and Detail S	pecificatio	on		fication Extension Report ence and date:	t			
Generic: 5000	•	3		□ (supply de	etails in Bo	ох	reiere	ence and date.				
				15)			STPS1045 Lot ID33510003ZE_Chart F4 9/2/18 STPS60A45 Lot ID33652003ZU Chart F4 (PINK hoven					
Detail(s): 5106/01 5106/01		3 5	Deviation from current Specifications:					qualification) 12/7/18 STPS80150 Lot ID33633001ZZ Chart F4 Sg1&3				
5106/01 5106/01		5 7					12/7/18					
5106/02 5106/02	3 3	3						20100 Lot ID33420006Z ation report STPS40170)	
3100/02			No 📈 Yes	□ (Supply d	letails)			(equivalent to STPS80A1 fication report STPS60A1				
								648006ZZ_Chart F4_sg2 ation report STPS3045:	&3.			
			Iss.1 Qualification report STPS60A45 (same die as									
								S80A45) Lot ID33652003				
											8	
Summary of procure	ment or equivalent	test r	esults during current vali	idity period in su	pport of th	nis ap	olicatio	n (those to ESCC listed f	irst)			
Project Name	Testing Le	evel	LAT		Date code			Quantity	Delive	ered		
PID changes since s	tart of qualification		9	Current PID V	,			CNES			10	
None 🛛								ve Representative Agen				
Minor*								21 and 8122351 (specifi Diodes) rev 15	c Pow	er		
Major* □	*Provide details in	box:		Issue: Rev Date: 1	2/02/2019	.		Date:		03/02/2020		
				Nev Date. 1	2/02/2013	2					11	
Current Manufacturir	ng facilities surveye	d by:	CNES				on	20	/05/20	19		
			(Name of Ex	ecutive Represe	entative) A	genc	y		(Date)	1		
Satisfactory:	Yes 🛛		No 🗆 Expla	ain								
Report Reference:	CR-Etude SM	<u>4D5</u> S	ST Mai 2019									

APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL Pag						
ESCC	Component title:	Appl. No.				
	Executive Member:	CNES	Date: 03/03/20	20 272H-rev2		
Failure Analysis, DPA, NCCS available:	Yes	□ No ⊠	(Supply data)	12		
Ref. No's and purposes:						
The undersigned hereby certifies on behal that the appropriate documentation has be (except as stated in box 15;) - that the repo CNES as the responsible Executive Memb	en evaluated; - that fu orts and data are avail	Il compliance to all Es able at the ESCC Exe	SCC requirements is evidence ecutive and therefore applies on behalf	of wrows		
Date: 03/03/2020				JP. BUSSENOT the Executive Coordinator)		
Continuation of Boxes above:				14		

		AP	PLICATION FOR EXTENSION OF ESCC QU	ALIFICATION APPROVAL	Page 3
100	FSCC	Componen	t title: Schottky Barrier Power Diodes bas	ed on type STPS	Appl. No.
		Executive N	Member: CNES	Date: 03/03/2020	272H-rev2
		Executive		2010. 00/00/2020	15
Non comp	pliance to ESCC requirements:		r	1	
No.:	Specification		Paragraph	Non compliar	nce
		mpliance for l	ESCC qualification or rationale for acceptabili	ty of	16
noncompl	liance: Environmental/mechanical sub	aroup and as	sombly/conshility subgroup :		10
-	SMD1 package covered by tes	sts on STPS8	0150		
	SMD.5 package covered by te TO254 package covered by te	sts on STPS1 sts on STPS2	045 20100		
-	Endurance subgroup :				
	STPS40100 covered by tests STPS80A150 covered by tests	on STPS6045	5 A 150		
	STPS40100 covered by tests	on STPS2010			
	STPS6045 covered by tests of	151751045			
-	Process modification : Soft solder die attach modifica	tion covered b	by tests on STPS60A45		
Executive	Manager Disposition				17
Applicatio	on Approval: Yes 🛛	No 🗆			
Action / R	Remarks:				
				Digitally	signed
				SH But by Britta Date: 202	Schade 20.03.27
Date:				10:01:19	
				B, Schade: Head of ESA Pro and Safety Depa	

	APPLICAT	Page 4							
ESCC	Component Title: Schottky Barrier Power Diodes based on type STPS					0.			
	Executive Member:	CNES	Date:	03/03/2020	272H-re	v2			
ANNEX 1: LIST OF TESTS DONE TO SUPPORT EXTENSION OF QUALIFICATION									
Tests conducted in compliance with:									
 ESCC 5000 generic specification; Chart F4 (for ESCC/QPL parts); or PID-TFD (for ESCC/QML parts) Tests vehicle identification/description:									
Tests vehicle identification/description:	(
Tests vehicle identification/description: STPS1045 Lot ID33510003ZE_Full Char DC1731	、	A150 Lot ID33648006ZZ_Chart F4 sg2&3]						

Chart F4	Test	Tick when done	Conditions	Date Code Diffusion	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
	Mechanical shock		MIL-STD-750 TM2016	Lot 1731 1627	45	0	,
	Vibration		MIL-STD-750 TM2016	1749 1731 1627	45	0	
	Constant acceleration		MIL-STD-750 TM2006	1749 1731 1627	45	0	
٩	Seal Fine leak		MIL-STD-750 TM2000	1749 1731 1627 1749	45	0	
Environmental/Mechanical Subgroup	Gross leak Electrical Measurement	\boxtimes	Intermediate and End- Point Electrical Measurements	1731 1627 1749	45	0	
lanical	External Visual	X	ESCC Basic Spec 20500	1731 1627 1749	45	0	
al/Mecha	Thermal shock		MIL-STD-750 TM1056	Click here to enter text.			Only applicable to axial lead glass diodes
nmen	Temperature Cycling	\boxtimes	MIL-STD-750 TM1051	1731 1627 1749	45	0	
Inviro	Moisture Resistance	\boxtimes	MIL-STD-750 TM1021	1731 1627 1749	45	0	
ш	Seal Fine leak Gross leak	X	MIL-STD-750 TM1071	1731 1627 1749	45	0	
	Electrical Measurement	X	Intermediate and End- Point Electrical Measurements	1731 1627 1749	45	0	
	External Visual	\boxtimes	ESCC Basic Spec 20500	1731 1627 1749	45	0	
dn	Operating Life	\boxtimes	ESCC 5000 Para. 8.19	1731 1627 1749	60	0	
Endurance Subgroup	Electrical Measurement	X	Intermediate and End- Point Electrical Measurements	1731 1627 1749	60	0	
durance	Seal Fine leak Gross leak	X	MIL-STD-750 TM1071	1731 1627 1749	60	0	
Ē	External Visual Inspection	\boxtimes	ESCC Basic Spec 20500	1731 1627 1749	60	0	
ity	Permanence of Marking		ESCC Basic Spec 24800				Not applicable on Laser marking
upabil	Terminal Strength	X	ESCC 5000 Para. 8.18	1731 1627 1749	20	0	
Assembly Capability Subgroup	Internal Visual	X	ESCC Basic Spec 20400	1731 1627 1749	20	0	
semt Su	Bond Strength	\boxtimes	MIL-STD-750 TM 2037	1731 1627 1749	12	0	
As	Die Shear	X	MIL-STD-750 TM 2017	1731 1627 1749	12	0	

		APPLICATIO		OF ESCC QUALIFIC		Page 7
E		Component title:		ver Diodes based on ty		
		Executive Member:	CNES	Da	te: 03/03/2020	Appl. No.
						272H-rev2
	S ON THE COMPLI	ETION OF THE APPL	LICATION FORM FOI	R ESCC QUALIFICAT	ION EXTENSION APPROVA	L
ENTRIES Form heading			t as given in its detail s ber and its sequential		ne of the series, family; - the E	xecutive Member;
Box 1	(the ESCC code is the detail specifica	s recommended to inc ation as 'base on'; -	dicate the values or va under Test Vehicle e	lues range, the tolera nter either an ESCC	or range of variants; - the rang nce, the voltage, etc); the de code or the specific charact t similar enter a cross if releva	signation given in eristic capable of
Box 2; 3 and 4	As per QPL entry;	otherwise, an explana	ation of the changes n	ust be supplied.		
Box 5					nd revision letter, current at t adate of the application, see E	
Box 6	deviations this mus	st be listed in Box 15.		specification in Box 5	in particular deviations from t have currently a different issu	
Box 7	Must reference the	e report(s) supplied in	support of the applica	tion.		
Box 8					all of which should already ha propriate table has been draw	
Box 9				st Extension of Qualifi changes shall be clear	cation, adequate details of su ly marked.	ch evolution shall
Box 10			late and actual date o puired date of extensio		te of verification of the curre	nt PID should be
Box 11	practices, procedu	res, material, etc. use	d in manufacturing the	components are as de	to unexplained changes occu escribed in the PID. This surve d its findings shall be recorded	ey shall be carried
Box 12		s) (NCCS) occurred d			and Failure Analysis reports if established corrective action	,
Box 13	Enter only the nar Coordinator.	ne of the Executive	Member (i.e., CNES,	DLR, ESTEC, etc.) a	nd the signature of the respo	onsible Executive
Box 14				from 1 through 12. Ide everal boxes have to b	entify box affected and reference oe expanded.	nce the Box 14 in
Box 15	Fill in Table as req	uested.				
Box 16				ember to bring the sub s) to accept the nonco	mitted data to a standard like mpliance.	ly to be accepted
Box 17		•			or restrictions, modifications o he representative for ESA, an	
Box 18	Fill in Table as req	uested.				
Box 19	Confidential Detail	s of PID changes incl	uding those of a confid	lential nature, shall be	provided.	
Box 20		nce with reference to Ily numbered. If releva		aragraph(s). To simpl	ify reference in Box 16 each	nonconformance
Box 21				ember to bring the sub s) to accept the nonco	mitted data to a standard like mpliance.	ly to be accepted
Box 22	Additional Comme	nts.				